Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/521,943	SUEHIRO ET AL.
Examiner	Art Unit

David J. Makiya

2875

	SEARCHED					
Class	Subclass	Date	Examiner			
362	294	9/8/2006	DJM			
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Search in EAST attached	9/8/2006	DJM	